

SIPMOS[®] Small-Signal-Transistor

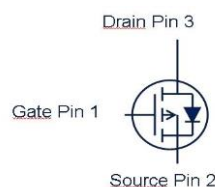
Features

- P-Channel
- Enhancement mode / Logic level
- Avalanche rated
- Pb-free lead plating; RoHS compliant
- Footprint compatible to SOT23
- Qualified according to AEC Q101
- Halogen free according to IEC61249-2-21



Product Summary

V_{DS}	-250	V
$R_{DS(on),max}$	11	Ω
I_D	-0.14	A



PG-SC59



Type	Package	Tape and Reel Information	Marking	Halogen-free	Packing
BSR92P	PG-SC59	H6327 = 3000 pcs. / reel	LD	Yes	Non dry

Maximum ratings, at $T_j=25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
			steady state	
Continuous drain current	I_D	$T_A=25\text{ °C}$	-0.14	A
		$T_A=70\text{ °C}$	-0.11	
		$T_A=25\text{ °C}$	-0.56	
Pulsed drain current	$I_{D,pulse}$	$T_A=25\text{ °C}$	-0.56	
Avalanche energy, single pulse	E_{AS}	$I_D=-0.14\text{ A}$, $R_{GS}=25\text{ }\Omega$	24	mJ
Gate source voltage	V_{GS}		± 20	V
Power dissipation	P_{tot}	$T_C=25\text{ °C}$	0.5	W
Operating and storage temperature	T_j , T_{stg}		-55 ... 150	°C
ESD class		JESD22-A114 (HBM)	1A (250V to 500V)	
Soldering temperature			260 °C	
IEC climatic category; DIN IEC 68-1			55/150/56	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - ambient	R_{thJA}	minimal footprint, steady state	-	-	250	K/W
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Electrical characteristics, at $T_j=25\text{ °C}$, unless otherwise specified
Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}$, $I_D=-250\text{ }\mu\text{A}$	-250	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=-130\text{ }\mu\text{A}$	-2	-1.5	-1	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=-250\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=25\text{ °C}$	-	-0.1	-1	μA
		$V_{DS}=-250\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=150\text{ °C}$	-	-10	-100	
Gate-source leakage current	I_{GSS}	$V_{GS}=-20\text{ V}$, $V_{DS}=0\text{ V}$	-	-10	-100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=-2.8\text{ V}$, $I_D=-0.025\text{ A}$	-	11	20	Ω
		$V_{GS}=-4.5\text{ V}$, $I_D=-0.13\text{ A}$	-	9	13	
		$V_{GS}=-10\text{ V}$, $I_D=-0.14\text{ A}$	-	8	11	
Transconductance	g_{fs}	$ V_{DS} >2 I_D R_{DS(on)max}$, $I_D=-0.11\text{ A}$	0.1	0.3	-	S

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics³⁾

Input capacitance	C_{iss}	$V_{GS}=0\text{ V}, V_{DS}=-25\text{ V},$ $f=1\text{ MHz}$	-	82	109	pF
Output capacitance	C_{oss}		-	12	16	
Reverse transfer capacitance	C_{rss}		-	5	8	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=-125\text{ V},$ $V_{GS}=-10\text{ V},$ $I_D=-0.14\text{ A}, R_{G,ext}=6\text{ }\Omega$	-	6.4	9.0	ns
Rise time	t_r		-	6.3	9.0	
Turn-off delay time	$t_{d(off)}$		-	75.0	112	
Fall time	t_f		-	71.0	163	

Gate Charge Characteristics^{2), 3)}

Gate to source charge	Q_{gs}	$V_{DD}=-200\text{ V}, I_D=-$ $0.14\text{ A}, V_{GS}=0\text{ to }-$ 10 V	-	-0.2	-0.3	nC
Gate to drain charge	Q_{gd}		-	-1.2	-1.8	
Gate charge total	Q_g		-	-3.6	-4.8	
Gate plateau voltage	$V_{plateau}$		-	-2.7	-	V

Reverse Diode

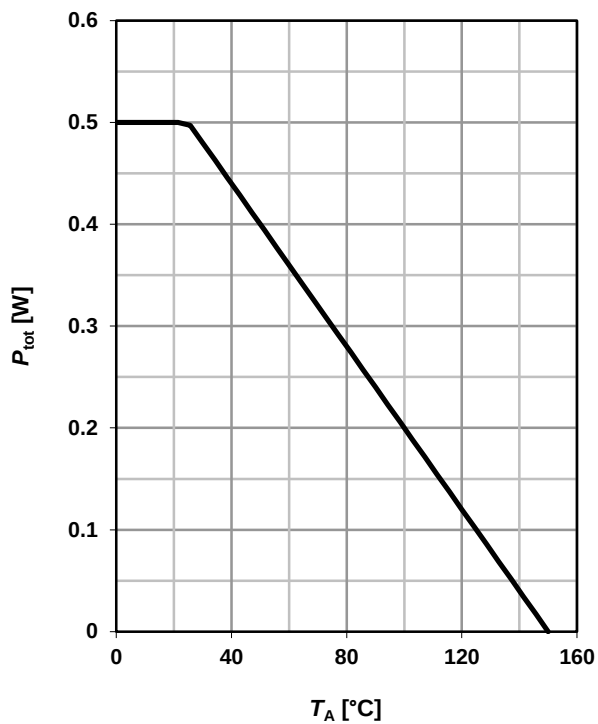
Diode continuous forward current	I_S	$T_C=25\text{ }^\circ\text{C}$	-	-	-0.14	A
Diode pulse current	$I_{S,pulse}$		-	-	-0.56	
Diode forward voltage	V_{SD}	$V_{GS}=0\text{ V}, I_F=0.14\text{ A},$ $T_J=25\text{ }^\circ\text{C}$	-	-0.8	-1.2	V
Reverse recovery time ³⁾	t_{rr}	$V_R=125\text{ V}, I_F= I_S ,$ $di_F/dt=100\text{ A}/\mu\text{s}$	-	66	-	ns
Reverse recovery charge ³⁾	Q_{rr}		-	125	-	nC

²⁾ See figure 16 for gate charge parameter definition

³⁾ Defined by design. Not subjected to production test

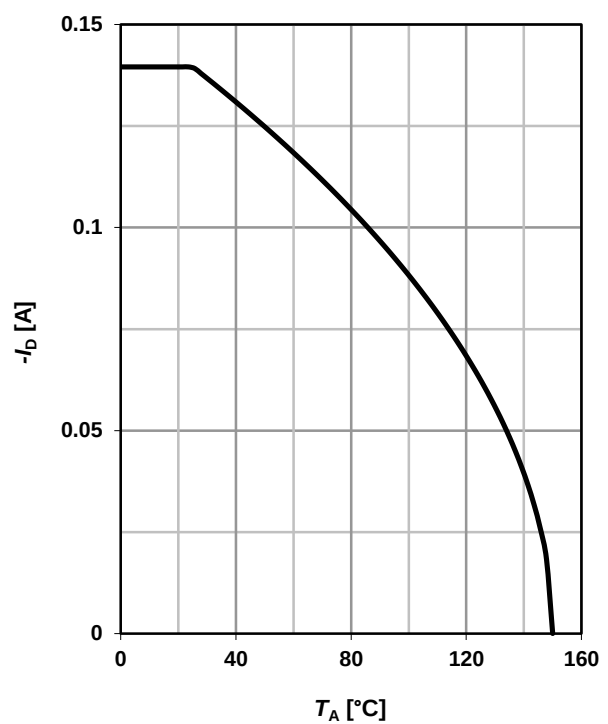
1 Power dissipation

$$P_{\text{tot}} = f(T_C)$$



2 Drain current

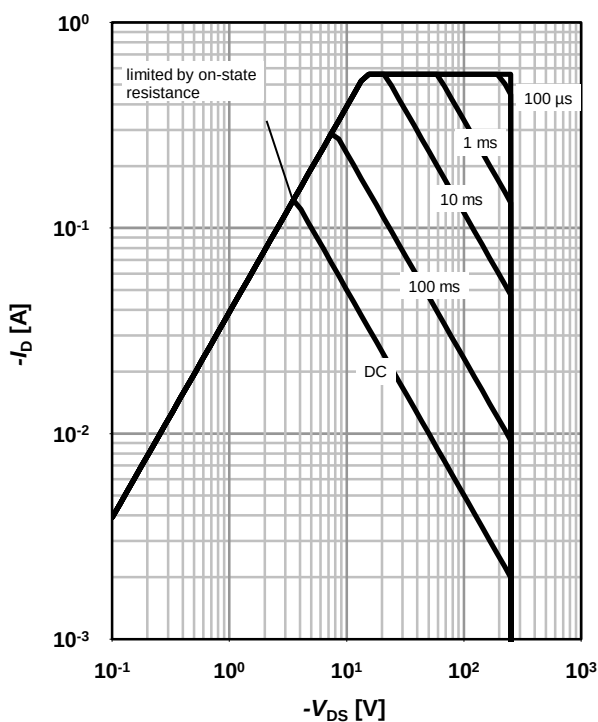
$$I_D = f(T_C); |V_{GS}| \geq 10 \text{ V}$$



3 Safe operating area

$$I_D = f(V_{DS}); T_C = 25 \text{ °C}; D = 0$$

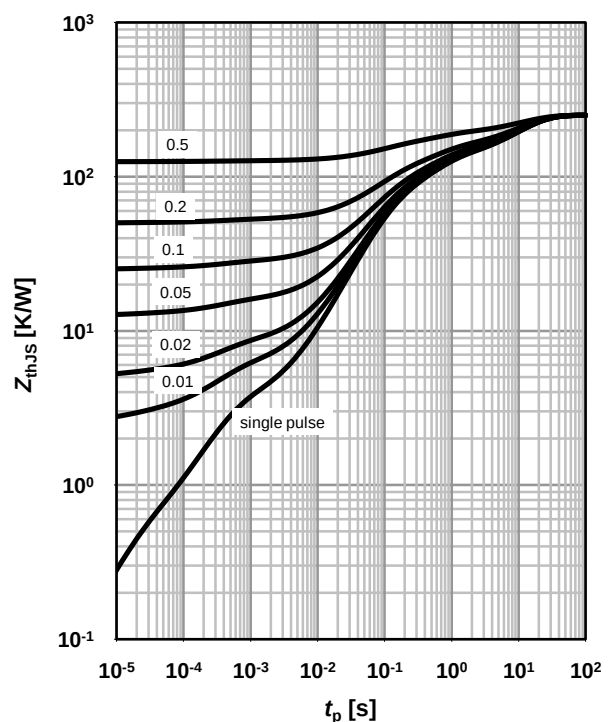
parameter: t_p



4 Max. transient thermal impedance

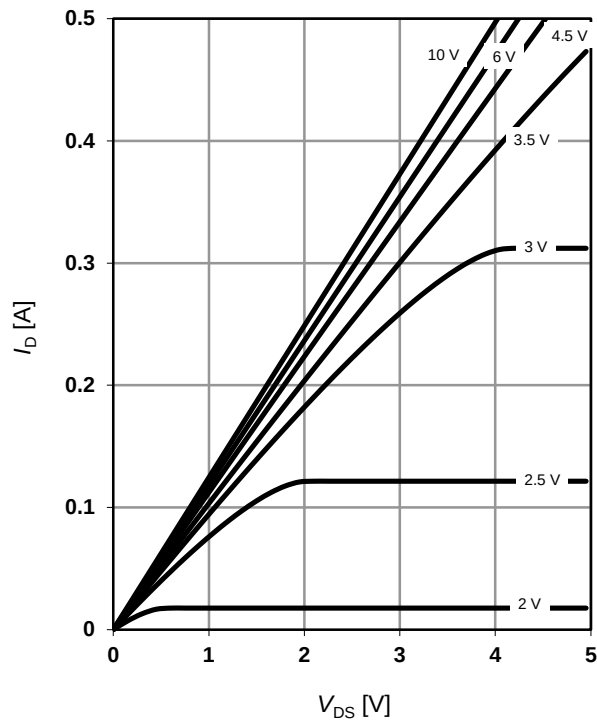
$$Z_{\text{thJC}} = f(t_p)$$

parameter: $D = t_p/T$



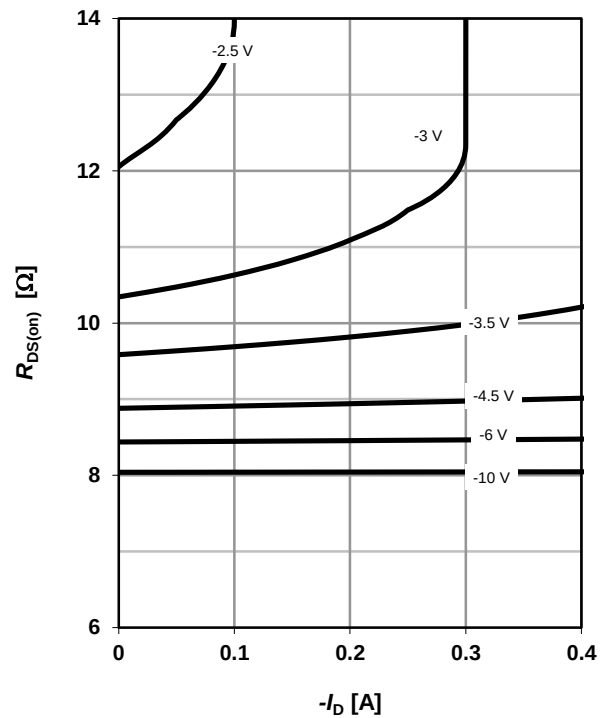
5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25^\circ\text{C}$

parameter: V_{GS}


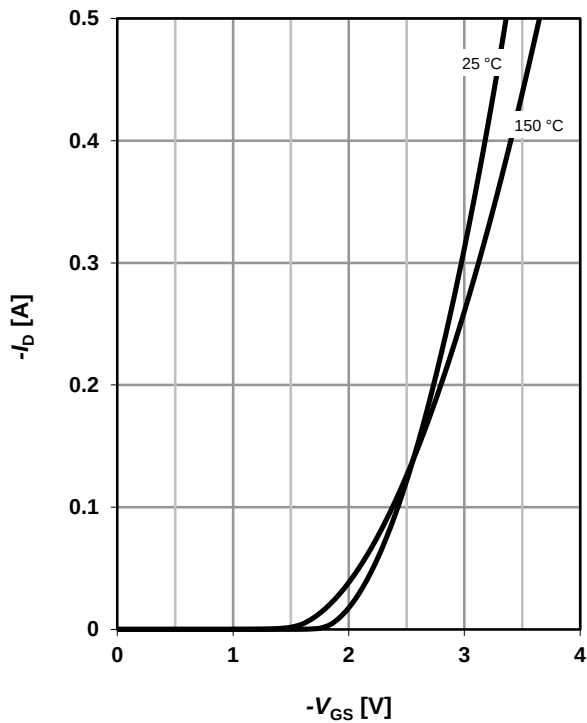
6 Typ. drain-source on resistance

 $R_{DS(on)} = f(I_D); T_j = 25^\circ\text{C}$

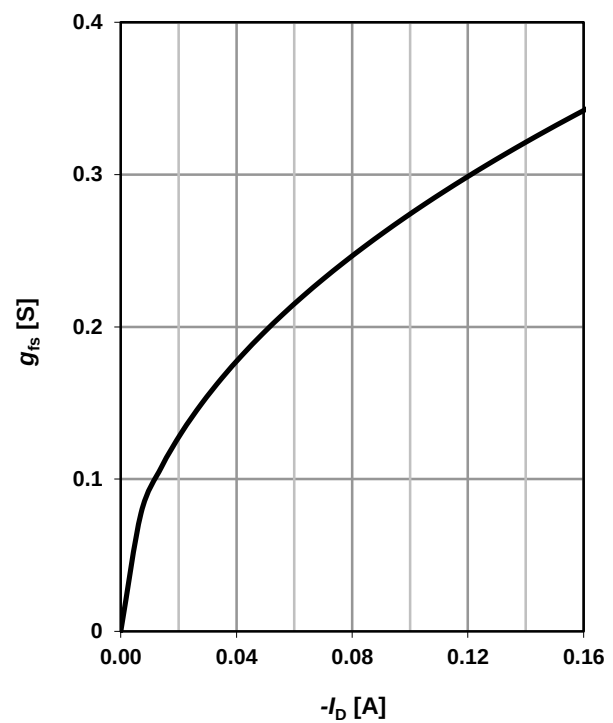
parameter: V_{GS}


7 Typ. transfer characteristics

 $I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}$

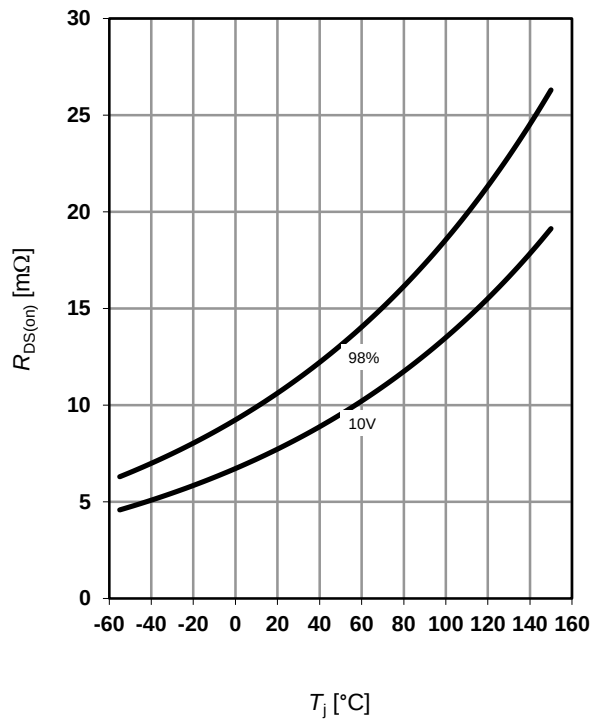
parameter: T_j


8 Typ. forward transconductance

 $g_{fs} = f(I_D); T_j = 25^\circ\text{C}$


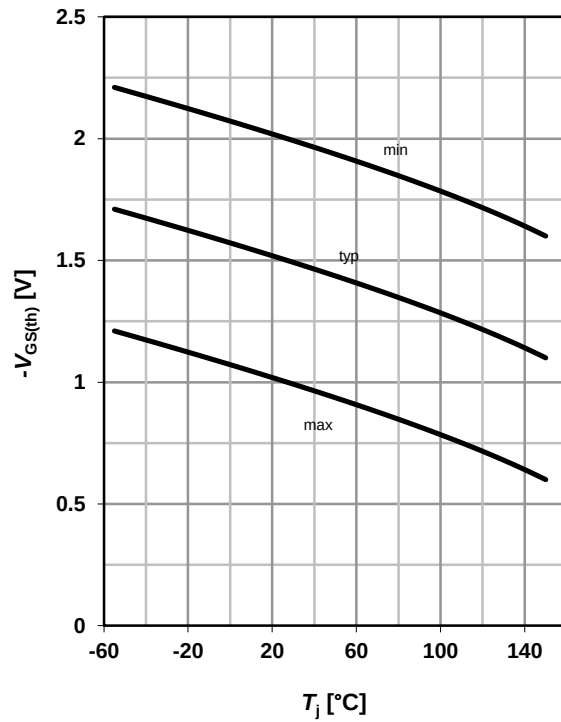
9 Drain-source on-state resistance

$$R_{DS(on)} = f(T_j); I_D = -0.14 \text{ A}; V_{GS} = -10 \text{ V}$$



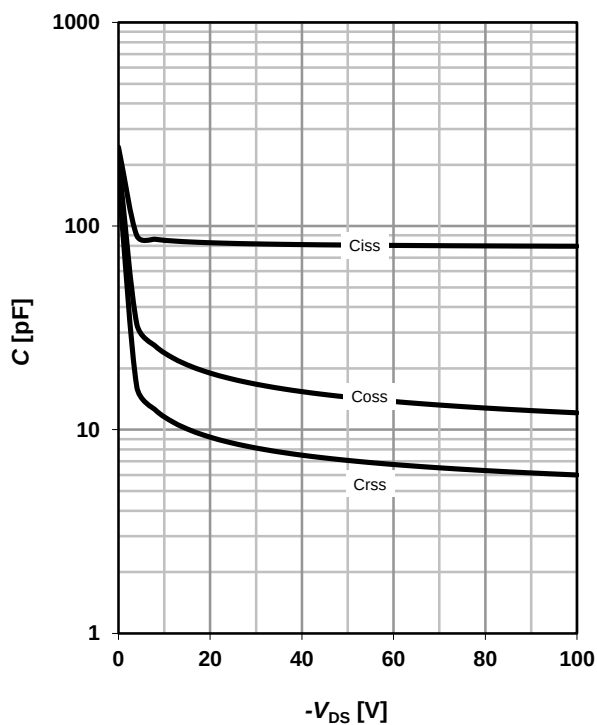
10 Typ. gate threshold voltage

$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}; I_D = -130 \mu\text{A}$$



11 Typ. capacitances

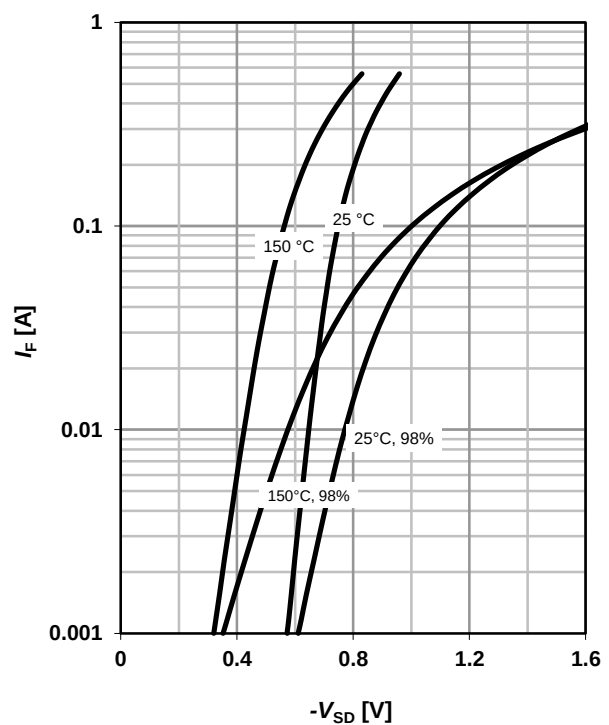
$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$



12 Forward characteristics of reverse diode

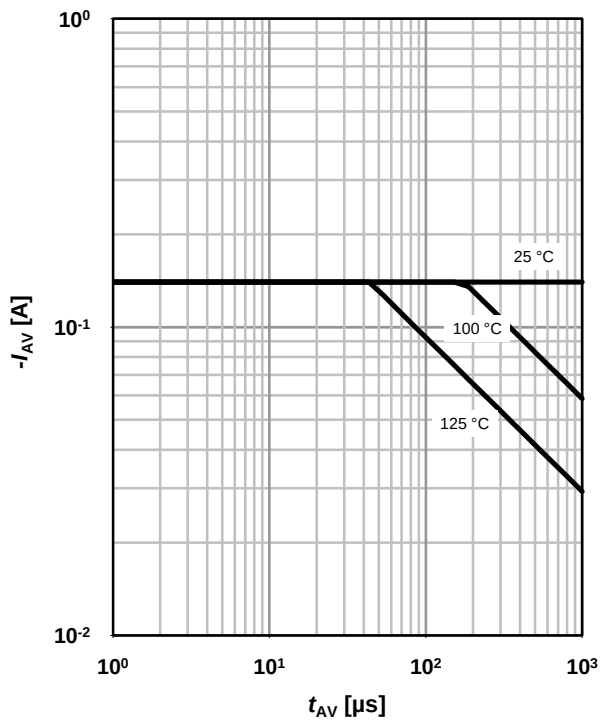
$$I_F = f(V_{SD})$$

parameter: T_j



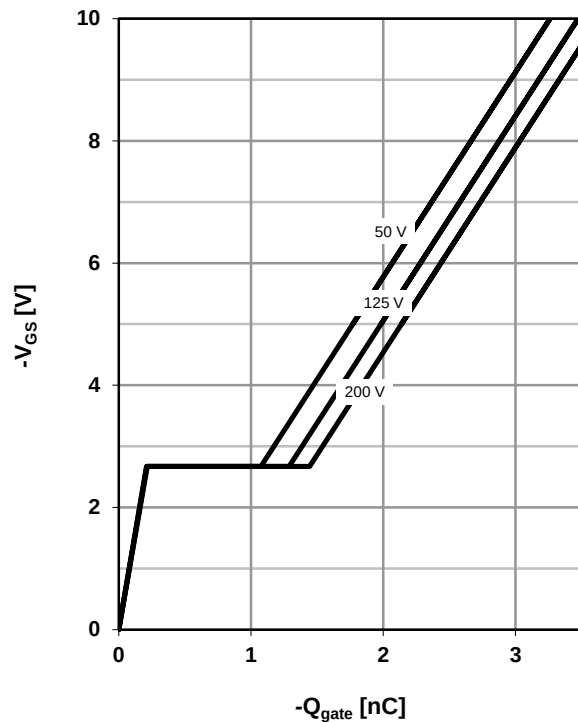
13 Avalanche characteristics

 $I_{AS}=f(t_{AV}); R_{GS}=25\ \Omega$

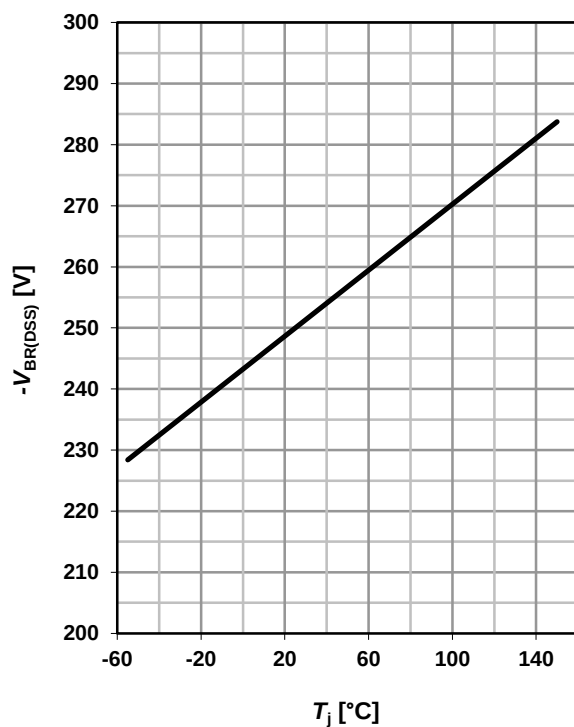
parameter: $T_{j(\text{start})}$


14 Typ. gate charge

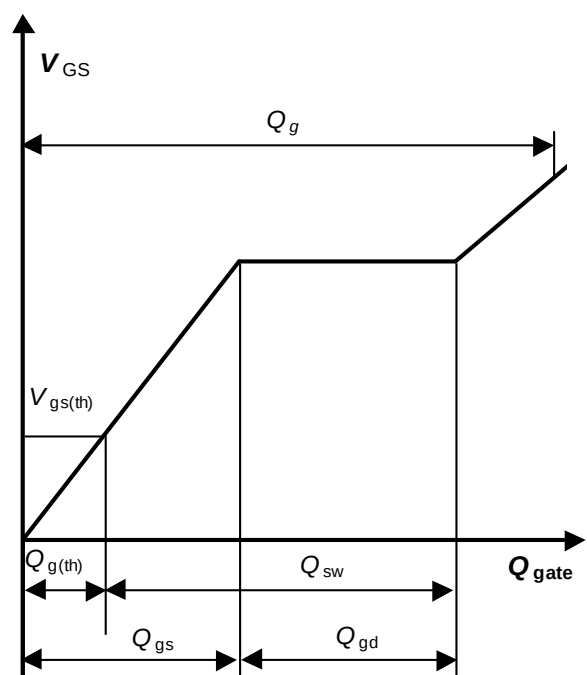
 $V_{GS}=f(Q_{gate}); I_D=-0.14\ \text{A pulsed}$

parameter: V_{DD}


15 Drain-source breakdown voltage

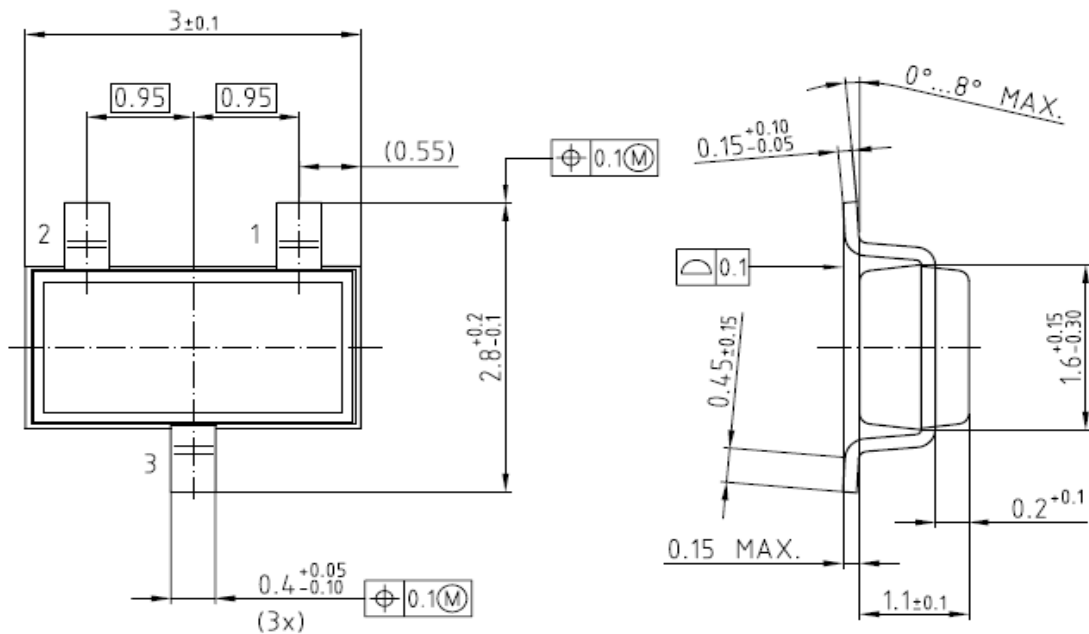
 $V_{BR(DSS)}=f(T_j); I_D=-250\ \mu\text{A}$


16 Gate charge waveforms

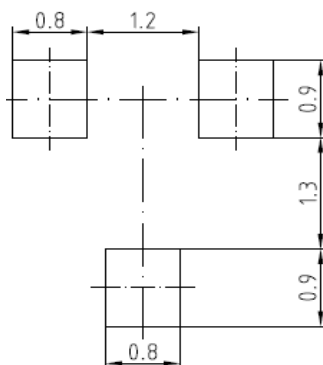


Package Outline

SC-59: Outline

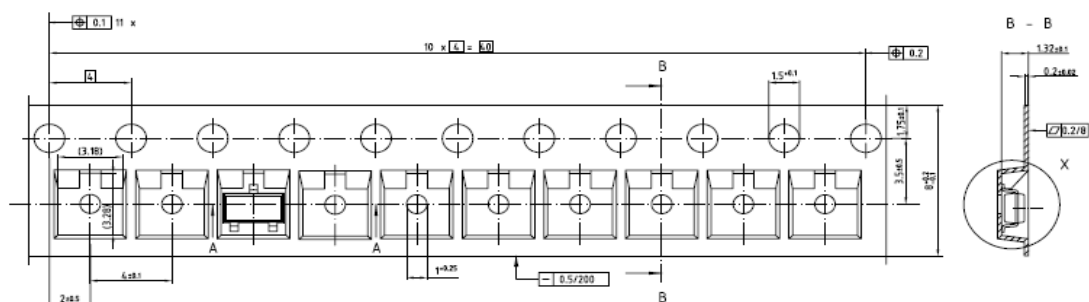


Footprint



Packaging

Tape



Dimensions in mm

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